

**Search Notes**

Application/Control No.

10/533,936

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

SON ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	270.1	8/2007	JS
430	905	L C	L C
430	910		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR